## Application/Control No. Applicant(s)/Patent Under Reexamination 09/963,474 OGAWA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Melur Ramakrishnaiah 2614 U.S. PATENT DOCUMENTS Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 348/14.08 US-6,515,695 02-2003 Sato et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY H04N 7/14 JP06-233289 08-1994 Tsutomu et al. Japan Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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